

SEMICONDUCTOR®

FQT1N80TF_WS N-Channel QFET® MOSFET 800V, 0.2 A, 20 Ω

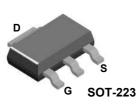
Description

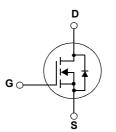
This N-Channel enhancement mode power MOSFET is produced using Fairchild Semiconductor®'s proprietary planar stripe and DMOS technology. This advanced MOSFET technology has been especially tailored to reduce on-state resistance, and to provide superior switching performance and high avalanche energy strength. These devices are suitable for switched mode power supplies, active power factor correction (PFC), and electronic lamp ballasts.



Features

- * 0.2 A, 800 V, R_{DS(on)}=15.5 $\Omega(V^{\text{``}}]$.)@V_{GS}=10 V, I_{D}=0.1 A
- Low Gate Charge (Typ. 5.5 nC)
- Low C_{rss} (Typ. 2.7 pF)
- 100% Avalanche Tested
- RoHS Compliant





MOSFET Maximum Ratings T_C = 25°C unless otherwise noted*

Symbol	Parameter			FQT1N80TF_WS	Unit
V _{DSS}	Drain to Source Voltage			800	V
V _{GSS}	Gate to Source Voltage			±30	V
ID	DrainCurrent	-Continuous (T _C = 25 ^o C)		0.2	
		-Continuous (T _C = 100 ^o C)		0.12	Α
I _{DM}	Drain Current	- Pulsed	0.8	А	
E _{AS}	Single Pulsed Avalanche	Energy	(Note 2)	90	mJ
I _{AR}	Avalanche Current		(Note 1)	0.2	А
E _{AR}	Repetitive Avalanche Ener	гду	(Note 1)	0.2	mJ
dv/dt	Peak Diode Recovery dv/dt (Note			4.0	V/ns
P _D	Dewer Dissignation	(T _C = 25°C)		2.1	W
	Power Dissipation	- Derate above 25°C		0.02	W/ºC
T _J , T _{STG}	Operating and Storage Temperature Range			-55 to +150	°C
TL	Maximum Lead Temperature for Soldering Purpose, 1/8" from Case for 5 Seconds			300	°C

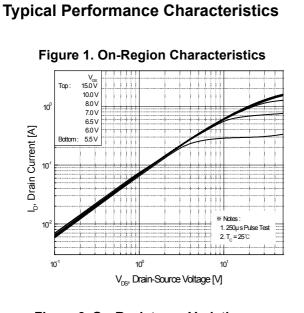
Thermal Characteristics

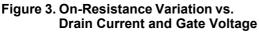
Symbol	Parameter	Min.	Max.	Unit
R_{\thetaJA}	Thermal Resistance, Junction to Ambient*	-	60	°C/W

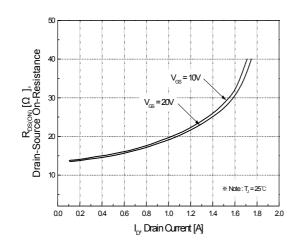
* When mounted on the minimum pad size recommended (PCB Mount)

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EOT1N	Device Marking Device		Package	Reel Size	Таре	Width		Quantit	v
<u> </u>		SOT-223	y		2mm		4000		
Electrica	l Cha	racteristics							
Symbol		Parameter		Test Conditions	;	Min.	Тур.	Max.	Unit
Off Charac	teristi	cs							
BV _{DSS}		n to Source Breakdown Voltage		I _D = 250μA, V _{GS} = 0V, T _J = 25 ^o C		800	-	-	V
ΔBV _{DSS} / ΔT _J	Breako	Breakdown Voltage Temperature Coefficient		$I_D = 250 \mu A$, Referenced to $25^{\circ}C$		-	0.8	-	V/º(
I _{DSS}	Zero G	Zero Gate Voltage Drain Current		$V_{DS} = 800V, V_{GS} = 0V$ $V_{DS} = 640V, T_{C} = 125^{\circ}C$				25 250	μA
I _{GSS}	Gate to Body Leakage Current			$V_{DS} = 640V, T_{C} = 123 C$ $V_{GS} = \pm 30V, V_{DS} = 0V$		-	-	±100	nA
			•						
	Characteristics			V - V I - 250 A	T	3.0		5.0	V
V _{GS(th)}		Threshold Voltage		$V_{GS} = V_{DS}, I_D = 250 \mu A$ $V_{GS} = 10V, I_D = 0.1A$		3.0	- 15.5	20	ν Ω
R _{DS(on)}	Static Drain to Source On Resistance Forward Transconductance			$V_{GS} = 10V, I_D = 0.1A$ (Note 4)		-	0.75	- 20	S
9 _{FS}					(1010 4)		0.10		0
•	Characteristics Input Capacitance					-	150	195	pF
C		everse Transfer Capacitance otal Gate Charge at 10V		V _{DS} = 25V, V _{GS} = 0V f = 1MHz	_	20	30	pF	
C _{oss}					-	2.7	5.0	pF	
C _{rss}						-	5.5	7.2	nC
Q _g				V _{DS} = 640V, I _D = 1A		-	1.1	-	nC
Q _{gs}		Gate to Source Gate Charge Gate to Drain "Miller" Charge			_	3.3	-	nC	
Q _{gd}					(Note 4, 5)	-	5.5		no
Switching	-	n Delay Time					10	30	ne
t _{d(on)} t		n Rise Time		V_{DD} = 400V, I_D = 1A R_G = 25 Ω (Note 4, 5)		-	25	60	ns ns
t _r		off Delay Time				-	15	40	ns
t _{d(off)} t _f		off Fall Time				_	25	60	ns
		de Characteristic	I		(1016 4, 3)	-	20	00	113
I _s		um Continuous Drain to	-	Forward Current		_		0.2	A
		um Pulsed Drain to Sou				-	-	0.8	A
I _{SM} V _{SD}		o Source Diode Forward				-	-	1.4	V
t _{rr}		e Recovery Time	-	$V_{GS} = 0V, I_{SD} = 0.2A$ $V_{GS} = 0V, I_{SD} = 1A$ $dI_F/dt = 100A/\mu s$ (Note 4)		-	300	-	ns
Q _{rr}		e Recovery Charge				-	0.6	-	μC









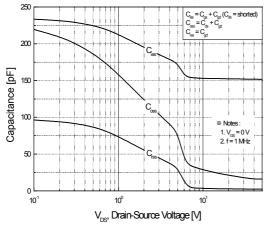
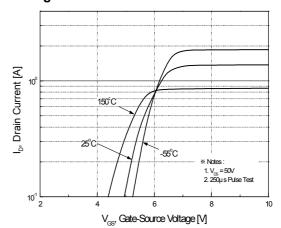
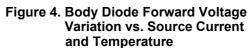


Figure 2. Transfer Characteristics





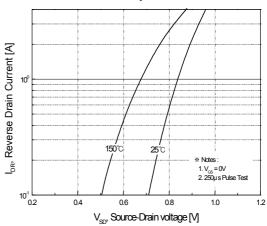
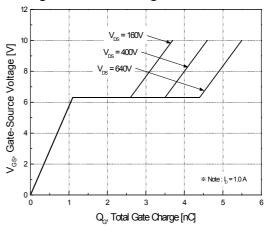
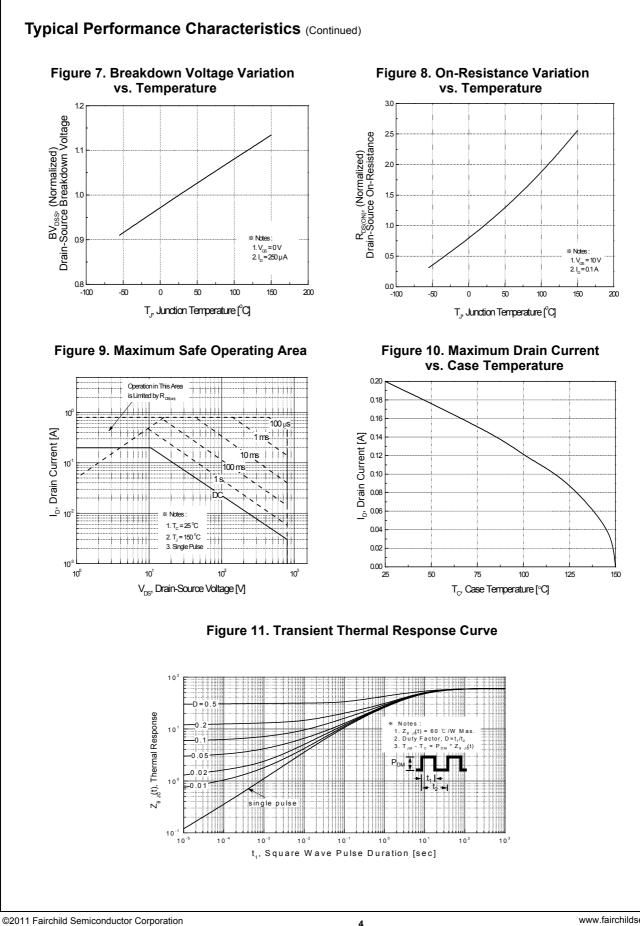


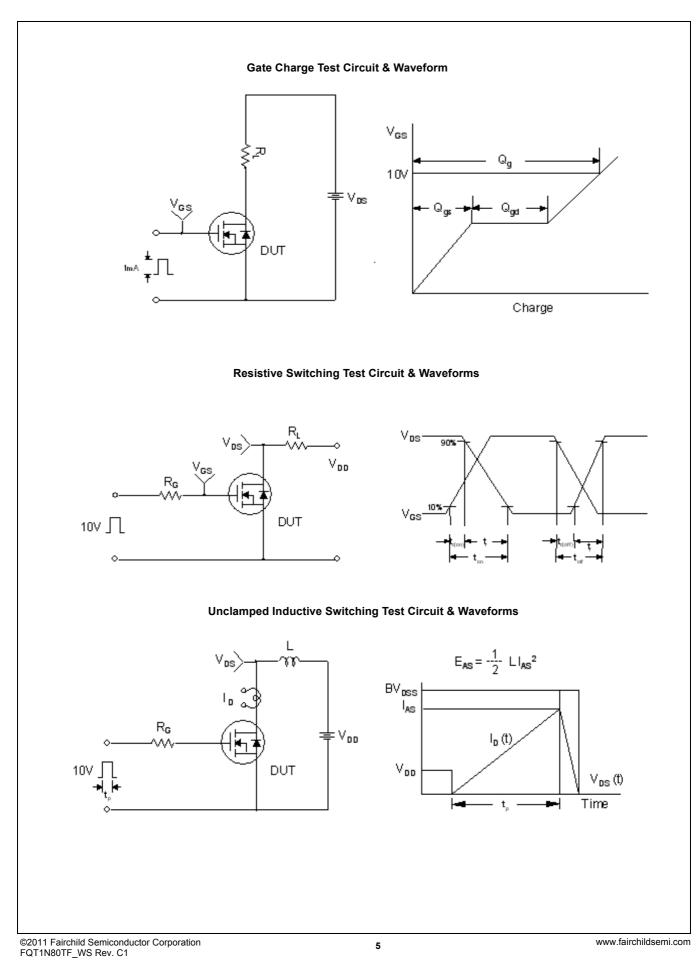
Figure 6. Gate Charge Characteristics

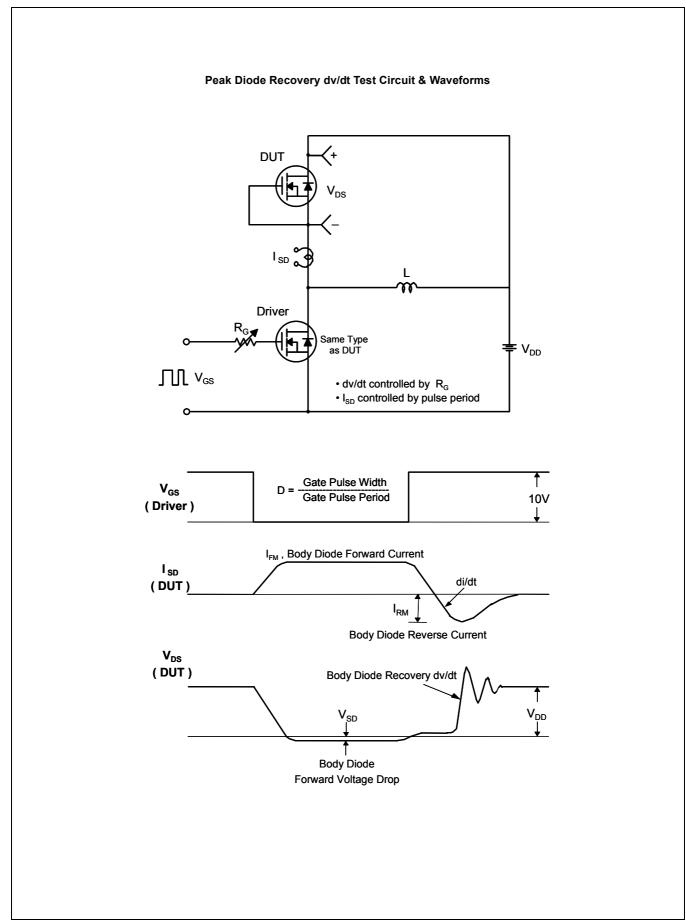


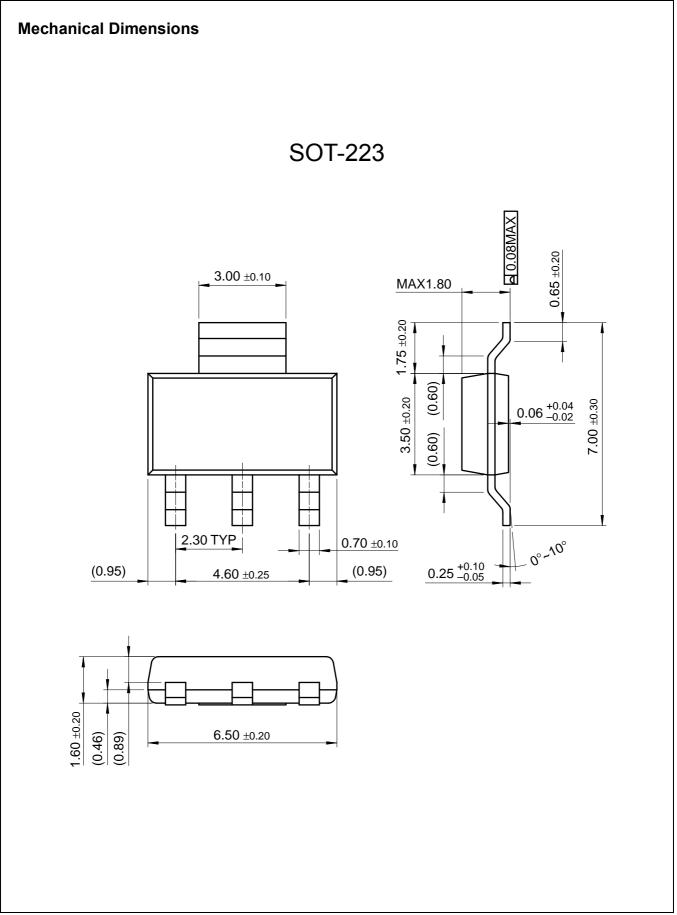
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